

Search Notes

Application/Control No.

10/840,189

Examiner

Jezia Riley

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

1637

SEARCHED

Class	Subclass	Date	Examiner
536	23.1 25.3 26.6		
548	100 120 146		
548	148 181		
548	215 217		
548	223		
435	6	7/13/2006	JR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
stn search enclosed	7/13/2006	JR